

Notice of References Cited

Application/Control No.

10/582,930

Applicant(s)/Patent Under
Reexamination
MEIER ET AL.

Examiner

NATHANIEL WIEHE

Art Unit

3745

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0111966	05-2005	Metheny, Alfred Paul	415/116
*	B	US-6,062,813	05-2000	Halliwell et al.	415/174.5
*	C	US-3,825,364	07-1974	Halila et al.	415/116
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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